DATA SHEET

BUT11APX-1200
Silicon Diffused Power Transistor

Product specification

April 1999

Silicon Diffused Power Transistor — BUT11APX-1200

GENERAL DESCRIPTION

Enhanced performance new generation,high voltage, high-speed switching npn transistor in a plastic full-pack envelope intended for use in horizontal deflection circuits of colour television receivers. Features exceptional tolerance to base drive and collector current load variations resulting in a very low worst case dissipation.

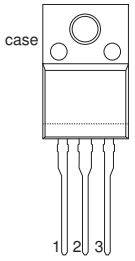
QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
V_{CESM}	Collector-emitter voltage peak value	V_{BE} = 0 V	-	1200	V
V_{CBO}	Collector-Base voltage (open emitter)		-	1200	V
V_{CEO}	Collector-emitter voltage (open base)		-	550	V
I_C	Collector current (DC)		-	6	A
I_{CM}	Collector current peak value		-	10	A
P_{tot}	Total power dissipation	$T_{hs} \leq 25$ ˚C	-	32	W
V_{CEsat}	Collector-emitter saturation voltage	I_C = 2 A; I_B = 0.4 A	0.15	1.0	V
h_{FEsat}	DC current gain	I_C = 3 A; V_{CE} = 5 V	15.5	-	
t_f	Fall time	I_C = 2.5 A; I_{B1} = 0.5 A	170	300	ns

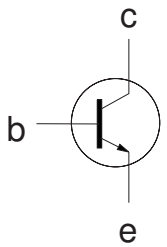
PINNING - SOT186A

PIN	DESCRIPTION
1	base
2	collector
3	emitter
case	isolated

PIN CONFIGURATION



SYMBOL



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum Rating System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{CESM}	Collector to emitter voltage	V_{BE} = 0 V	-	1200	V
V_{CEO}	Collector to emitter voltage (open base)		-	550	V
V_{CBO}	Collector to base voltage (open emitter)		-	1200	V
I_C	Collector current (DC)		-	6	A
I_{CM}	Collector current peak value		-	10	A
I_B	Base current (DC)		-	3	A
I_{BM}	Base current peak value		-	5	A
P_{tot}	Total power dissipation	$T_{hs} \leq 25$ ˚C	-	32	W
T_{stg}	Storage temperature		-65	150	˚C
T_j	Junction temperature		-	150	˚C

THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
$R_{th\ j\text{-}hs}$	Junction to heatsink	with heatsink compound	-	3.95	K/W
$R_{th\ j\text{-}a}$	Junction to ambient	in free air	55	-	K/W

ISOLATION LIMITING VALUE & CHARACTERISTIC

T_{hs} = 25 ˚C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V_{isol}	R.M.S. isolation voltage from all three terminals to external heatsink	f = 50-60 Hz; sinusoidal waveform; R.H. ≤ 65% ; clean and dustfree	-	-	2500	V
C_{isol}	Capacitance from T2 to external heatsink	f = 1 MHz	-	10	-	pF

STATIC CHARACTERISTICS

T_{hs} = 25 ˚C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I_{CES}	Collector cut-off current [1]	V_{BE} = 0 V; V_{CE} = $V_{CESMmax}$	-	-	1.0	mA
I_{CES}		V_{BE} = 0 V; V_{CE} = $V_{CESMmax}$; T_j = 125 ˚C	-	-	2.0	mA
I_{EBO}	Emitter cut-off current	V_{EB} = 7 V; I_C = 0 A	-	-	0.1	mA
$V_{CEOsust}$	Collector-emitter sustaining voltage	I_B = 0 A; I_C = 10 mA; L = 25 mH	550	-	-	V
V_{CEsat}	Collector-emitter saturation voltage	I_C = 2.0 A; I_B = 0.4 A	-	0.15	1.0	V
V_{BEsat}	Base-emitter saturation voltage	I_C = 2.0 A; I_B = 0.4 A	-	0.91	1.5	V
h_{FE}	DC current gain	I_C = 1 mA; V_{CE} = 5 V	13	25	-	
h_{FE}		I_C = 500 mA; V_{CE} = 5 V	20	30	47	
h_{FEsat}	DC current gain	I_C = 2 A; V_{CE} = 5 V	13	18.5	25	
h_{FEsat}		I_C = 3.0 A; V_{CE} = 5 V	-	15.5	-	

DYNAMIC CHARACTERISTICS

T_{hs} = 25 ˚C unless otherwise specified8

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
	Switching times (resistive load)	I_{Con} = 2.5 A; I_{Bon} = -I_{Boff} = 0.5 A; R_L = 75 ohms; V_{BB2} = 4 V;			
t_{on}	Turn-on time		-	0.5	µs
t_s	Turn-off storage time		-	3	µs
t_f	Turn-off fall time		-	0.3	µs
	Switching times (inductive load)	I_{Csat} = 2.5 A; I_{B1} = 0.5 A; L_B = 1 µH; -V_{BB} = 5 V			
t_s	Turn-off storage time		-	1.5	µs
t_f	Turn-off fall time		170	300	ns
	Switching times (inductive load)	I_{Csat} = 2.5 A; I_{B1} = 0.5 A; L_B = 1 µH; -V_{BB} = 5 V; T_j = 100 ˚C			
t_s	Turn-off storage time		-	1.8	µs
t_f	Turn-off fall time		-	300	ns

1 Measured with half sine-wave voltage (curve tracer).

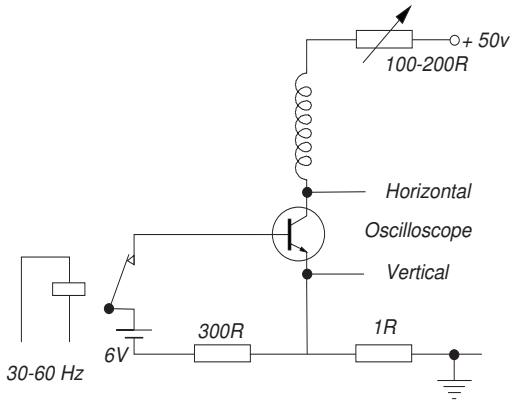


Fig.1. Test circuit for $V_{CEOsust}$.

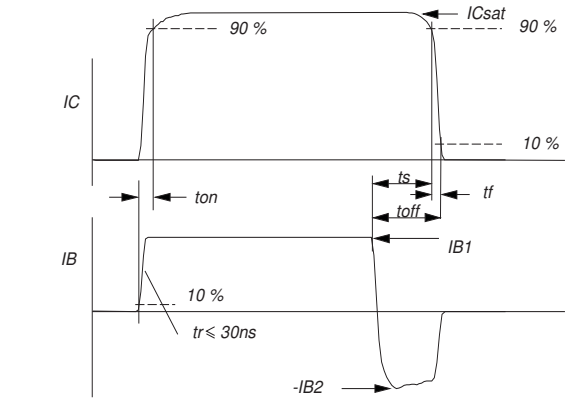


Fig.4. Switching times waveforms with resistive load.

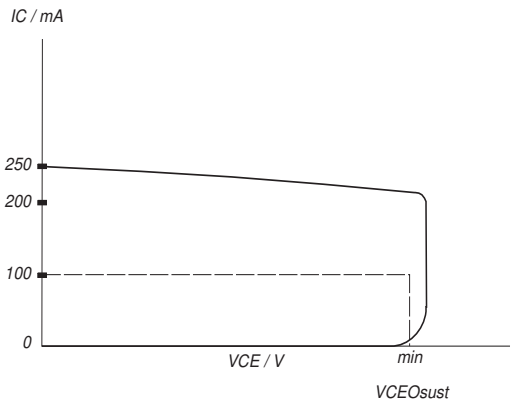


Fig.2. Oscilloscope display for $V_{CEOsust}$.

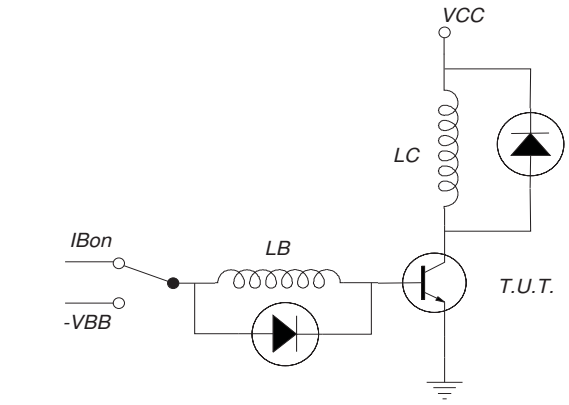


Fig.5. Test circuit inductive load.
V_{CC} = 300 V; $-V_{BE}$ = 5 V; L_C = 200 uH; L_B = 1 uH

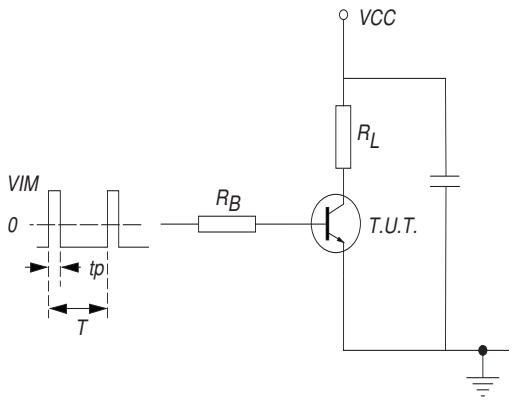


Fig.3. Test circuit resistive load. V_{IM} = -6 to +8 V
V_{CC} = 250 V; t_p = 20 μs; δ = t_p / T = 0.01.
R_B and R_L calculated from I_{Con} and I_{Bon} requirements.

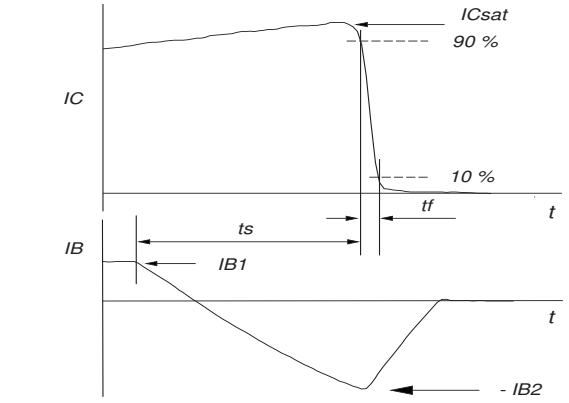


Fig.6. Switching times waveforms with inductive load.

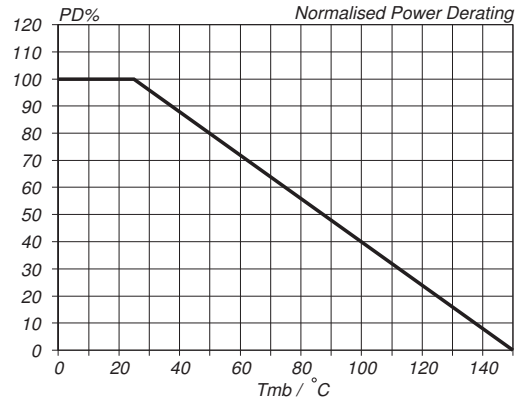


Fig.7. Normalised power dissipation. PD% = 100·PD/PD $_{25°C}$ = f (T_{hs})

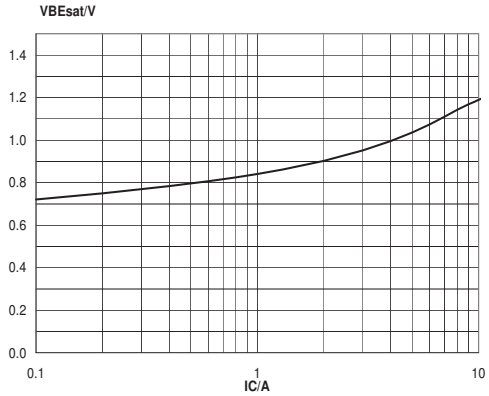


Fig.10. Base-Emitter saturation voltage. Solid lines = typ values, V_{BEsat} = f(IC); at IC/IB =4.

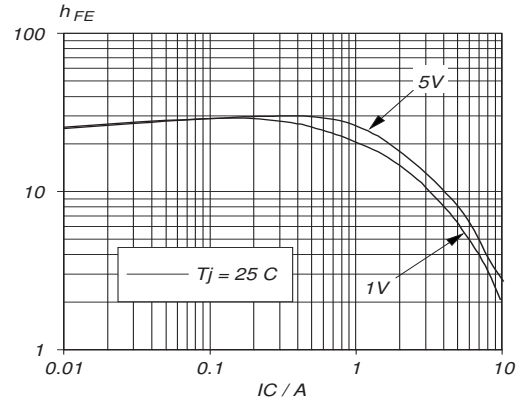


Fig.8. Typical DC current gain. h_{FE} = f(I_C) parameter V_{CE}

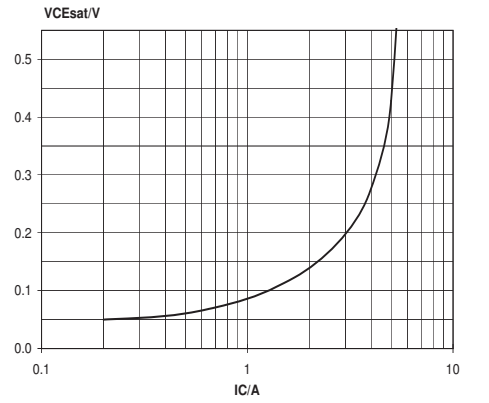


Fig.11. Collector-Emitter saturation voltage. Solid lines = typ values, V_{CEsat} = f(IC); at IC/IB =4.8

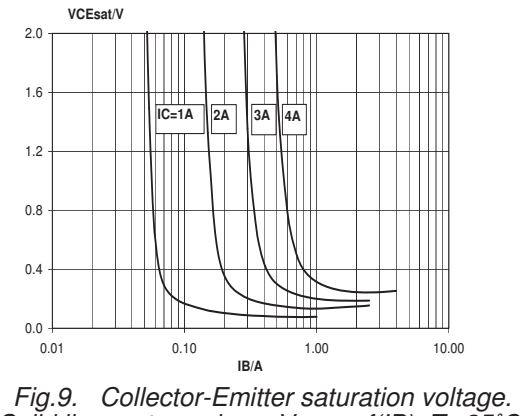


Fig.9. Collector-Emitter saturation voltage. Solid lines = typ values, V_{CEsat} = f(IB); T_j=25˚C.

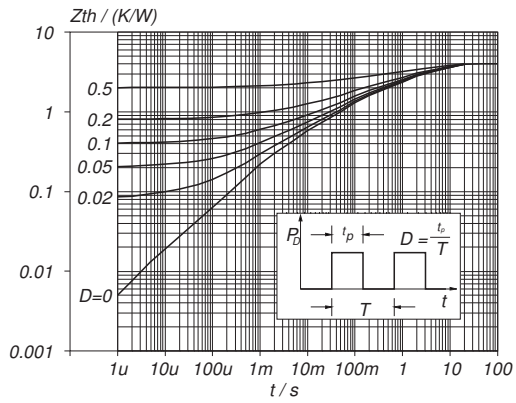


Fig.12. Transient thermal impedance. $Z_{th\ j\text{-}hs}$ = f(t); parameter D = t_p/T

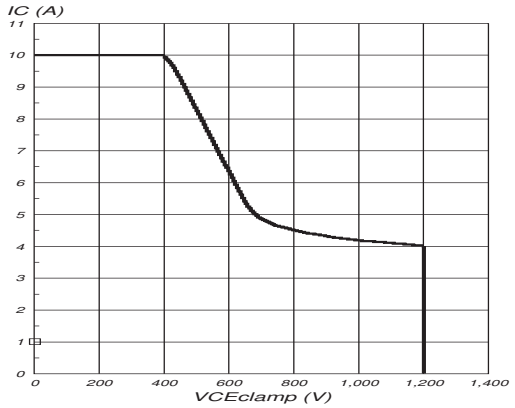


Fig.13. Reverse bias safe operating area. $T_j \leq T_{j\,max}$

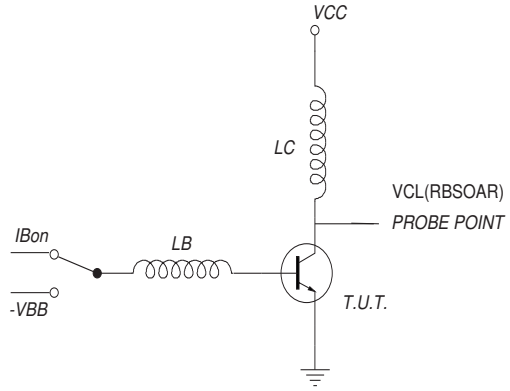


Fig.14. Test circuit for reverse bias safe operating area.
$V_{cl} \leq 1200V$; $V_{cc} = 150V$; $V_{BB} = -5V$; $L_B = 1\mu H$;$L_c = 200\mu H$

MECHANICAL DATA

Dimensions in mm

Net Mass: 2 g

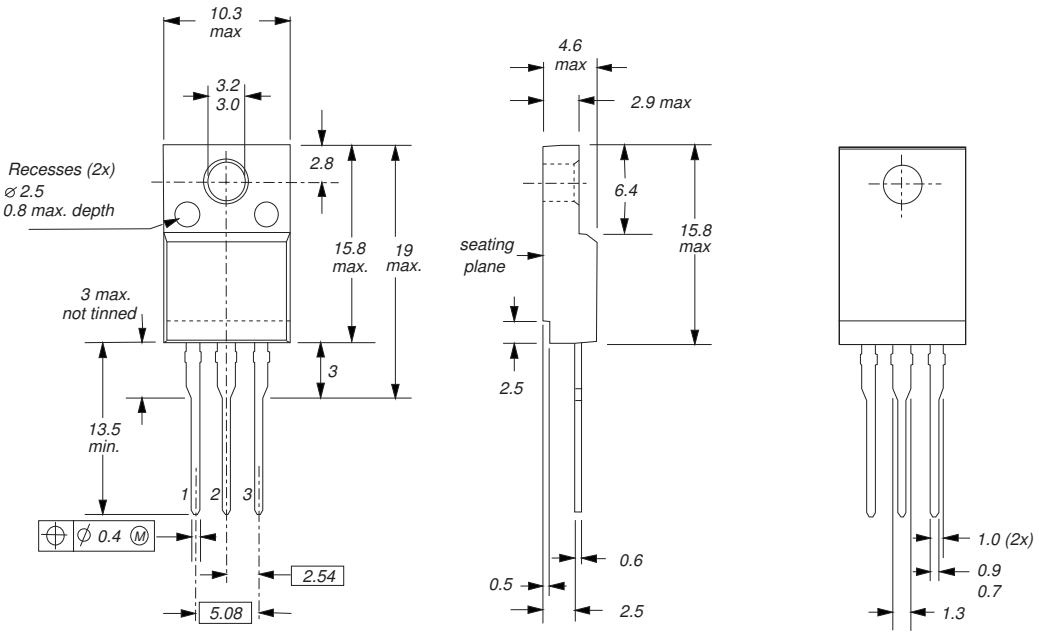


Fig.15. SOT186A; The seating plane is electrically isolated from all terminals.

Notes

1. Refer to mounting instructions for F-pack envelopes.
2. Epoxy meets UL94 V0 at 1/8".

Legal information

DATA SHEET STATUS

DOCUMENT STATUS[1]	PRODUCT STATUS[2]	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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